

# INFORMATION DISCLOSURE CITATION IN AN APPLICATION

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## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
<i>TLm</i>		US 6,957,318 B2	12/02/2003	Ishikawa et al.	
<i>TLm</i>		US 6,954,751	04/26/2000	Ichikawa et al.	
<i>TLm</i>		US 6,591,406 B2	07/08/2003	Ishikawa	
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## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code-Number 4-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No
<i>TLm</i>		JP 07-263324	10/13/1995	DAINIPPON SCREEN MFG		JAPAN (w/English Abstract)
<i>TLm</i>		JP 2002-329316 A	08/14/2002	DAINIPPON PRINTING CO LTD		JAPAN (w/English Abstract)

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER

*E. V. Maut*

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